

FQD4N50 / FQU4N50 N-Channel QFET® MOSFET

500 V, 2.6 A, 2.7 Ω

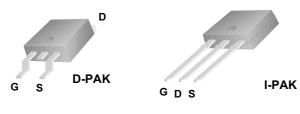
Description

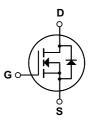
This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.



Features

- * 2.6 A, 500 V, $R_{DS(on)}$ =2.7 $\Omega(Max.)$ @ V_{GS} =10 V, I_D =1.3 A
- Low Gate Charge (Typ. 10 nC)
- Low C_{rss} (Typ. 6.0 pF)
- · 100% Avalanche Tested





Absolute Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter		FQD4N50 / FQU4N50	Unit
V_{DSS}	Drain-Source Voltage		500	V
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		2.6	Α
			1.64	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	10.4	Α
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	260	mJ
I _{AR}	Avalanche Current	(Note 1)	2.6	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	4.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
P _D	Power Dissipation (T _A = 25°C) *		2.5	W
	Power Dissipation (T _C = 25°C)		45	W
	- Derate above 25°C		0.36	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		2.78	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		110	°C/W

^{*} When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions		Min	Тур	Max	Unit
Off Cha	aracteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced	to 25°C		0.38		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 500 V, V _{GS} = 0 V				1	μА
		V _{DS} = 400 V, T _C = 125°C				10	μA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V				100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V		-		-100	nA
On Cha	racteristics	,				I.	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I = 1.3 A			2.0	2.7	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 50 V, I _D = 1.3 A	(Note 4)	-	2.6		S
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz			350	460	pF
Coss	Output Capacitance				55	70	pF
C _{rss}	Reverse Transfer Capacitance				6	8	pF
Switchi	ing Characteristics						
t _{d(on)}	Turn-On Delay Time	V_{DD} = 250 V, I_{D} = 3.4 A, R_{G} = 25 Ω (Note 4, 5)			12	30	ns
t _r	Turn-On Rise Time			-	45	100	ns
t _{d(off)}	Turn-Off Delay Time				20	50	ns
t _f	Turn-Off Fall Time			-	30	70	ns
Q _g	Total Gate Charge	V _{DS} = 400 V, I _D = 3.4 A,			10	13	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 10 \text{ V}$			2.5		nC
Q _{gd}	Gate-Drain Charge		(Note 4, 5)	-	4.7		nC
Drain-S	Source Diode Characteristics a	nd Maximum Ratings					
I _S	Maximum Continuous Drain-Source Diode Forward Current				2.6	Α	
I _{SM}	Maximum Pulsed Drain-Source Diode F	laximum Pulsed Drain-Source Diode Forward Current				10.4	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 2.6 \text{ A}$				1.4	V
v SD	Dialii-Source Diode Forward voltage	VGS - 0 V, IS - 2.0 A				1.4	v

 $dI_F / dt = 100 A/\mu s$

(Note 4)

1.15

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Q_{rr}

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 68mH, I_{AS} = 2.6A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25°C 3. I_{SD} \leq 3.4A, $di/dt \leq$ 200A/µs, V_{DD} \leq BV_{DSS}, Starting T_{J} = 25°C 4. Pulse Test : Pulse width \leq 300µs, Duty cycle \leq 2% 5. Essentially independent of operating temperature

Reverse Recovery Charge

μС

Typical Characteristics

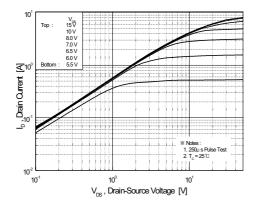


Figure 1. On-Region Characteristics

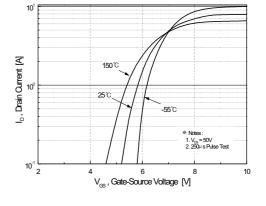


Figure 2. Transfer Characteristics

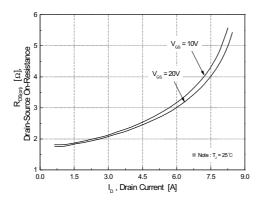


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

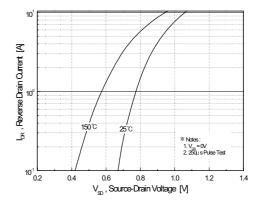


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

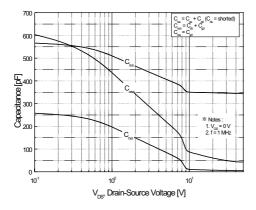


Figure 5. Capacitance Characteristics

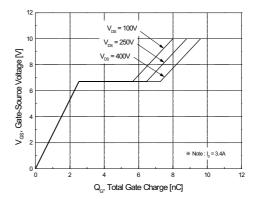


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

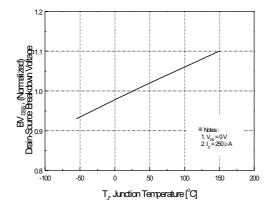


Figure 7. Breakdown Voltage Variation vs. Temperature

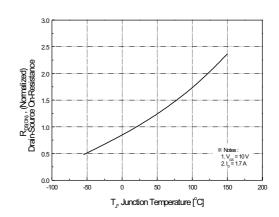


Figure 8. On-Resistance Variation vs. Temperature

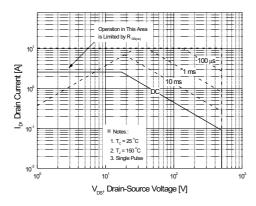


Figure 9. Maximum Safe Operating Area

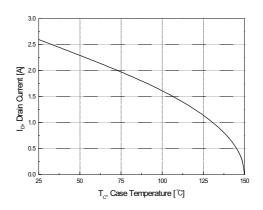


Figure 10. Maximum Drain Current vs. Case Temperature

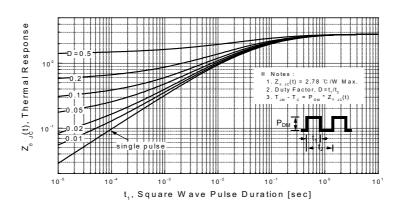
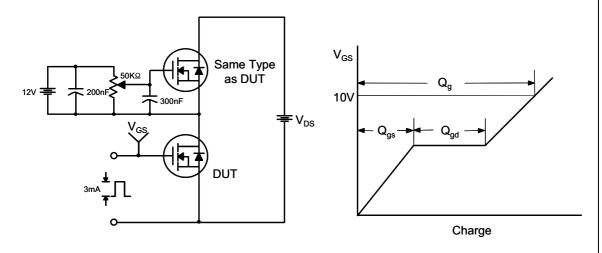
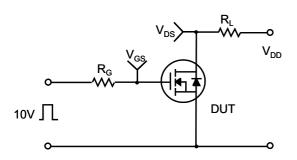


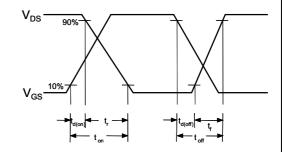
Figure 11. Transient Thermal Response Curve

Gate Charge Test Circuit & Waveform

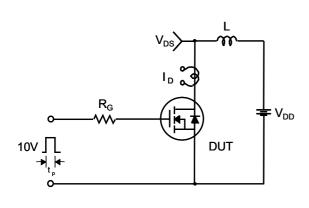


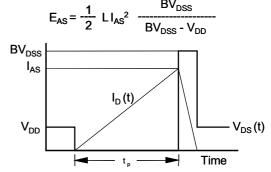
Resistive Switching Test Circuit & Waveforms



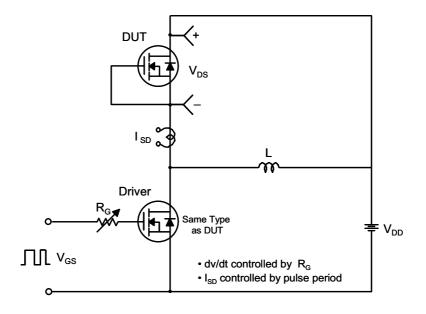


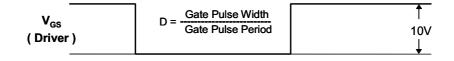
Unclamped Inductive Switching Test Circuit & Waveforms

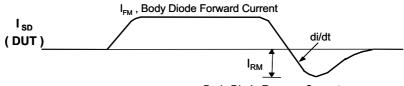




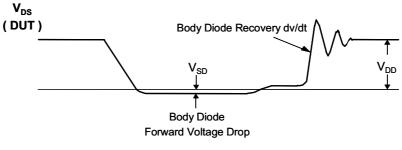
Peak Diode Recovery dv/dt Test Circuit & Waveforms







Body Diode Reverse Current



Mechanical Dimensions D-PAK - A 6.73 6.35 -6.00 MIN --6.50 MIN _1.02 MAX 6.25 C 3.00 MIN (0.59)1.40 MIN-2.30 2.29 ⊕ 0.25**(**) A() C **- 4.60 →** 4.57 LAND PATTERN RECOMMENDATION SEE NOTE D 4.32 MIN 0.58 5.21 MIN SEE DETAIL A △ 0.10 B NOTES: UNLESS OTHERWISE SPECIFIED A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA. B) ALL DIMENSIONS ARE IN MILLIMETERS. C) DIMENSIONING AND TOLERANCING PER 1. ASME Y14.5M-1994. D) HEAT SINK TOP EDGE COULD BE IN CHAMFERED CORNERS OR EDGE PROTRUSION. E) PRESENCE OF TRIMMED CENTER LEAD IS OPTIONAL. F) DIMENSIONS ARE EXCLUSSIVE OF BURSS, MOLD FLASH AND TIE BAR EXTRUSIONS. G) LAND PATTERN RECOMENDATION IS BASED ON IPC7351A STD TO220P1003X238-3N. H) DRAWING NUMBER AND REVISION: MKT-T0252A03REV8 0.51 GAGE PLANE 0.61 0.46 (1.54)10 1.78 1.40 0.127 MAX - SEATING PLANE (2.90) DETAIL A (ROTATED -90°) SCALE: 12X **Dimensions in Millimeters**

Mechanical Dimensions I-PAK 2.50 _ 1.27 _ 0.50 - 0.60 0.40 6.30 5.90 2.28 1.60 C 9.65 8.90 1.14 (0.60)2.29 → 0.25M AM C -NOTES: UNLESS OTHERWISE SPECIFIED ALL DIMENSIONS ARE IN MILLIMETERS. THIS PACKAGE CONFORMS TO JEDEC, TO-251, ISSUE C, VARIATION AA, DATED SEP 1988. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994. Dimensions in Millimeters





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